

TC74VHCT374AF, TC74VHCT374AFW, TC74VHCT374AFT

OCTAL D - TYPE FLIP - FLOP WITH 3 - STATE OUTPUT

The TC74VHCT374A is an advanced high speed CMOS OCTAL FLIP - FLOP with 3 - STATE OUTPUT fabricated with silicon gate C²MOS technology. It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation. This 8 - bit D - type flip - flop is controlled by a clock input (CK) and a output enable input (OE). When the OE input is high, the eight outputs are in a high impedance state. The input voltage are compatible with TTL output voltage. This device may be used as a level converter for interfacing 3.3V to 5V system. Input protection and output circuit ensure that 0 to 5.5V can be applied to the input and output*1 pins without regard to the supply voltage. These structure prevents device destruction due to mismatched supply and input / output voltages such as battery back up, hot board insertion, etc.

*1: output in off-state

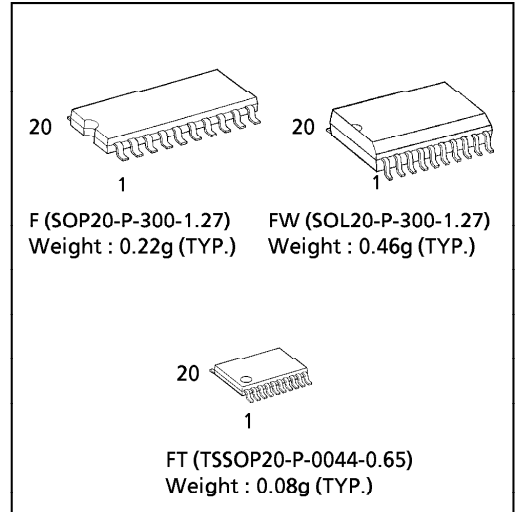
FEATURES :

- High Speed..... $f_{MAX} = 140\text{MHz}(\text{typ.})$ at $V_{CC} = 5\text{V}$
- Low Power Dissipation..... $I_{CC} = 4\mu\text{A}(\text{Max.})$ at $T_a = 25^\circ\text{C}$
- Compatible with TTL outputs.... $V_{IL} = 0.8\text{V}(\text{Max.})$
 $V_{IH} = 2.0\text{V}(\text{Min.})$
- Power Down Protection is provided on all inputs and outputs.
- Balanced Propagation Delays..... $t_{PLH} \approx t_{PHL}$
- Low Noise $V_{OLP} = 1.6\text{V}(\text{Max.})$
- Pin and Function Compatible with the 74 series (74AC / HC / F / ALS / LS etc.) 374 type.

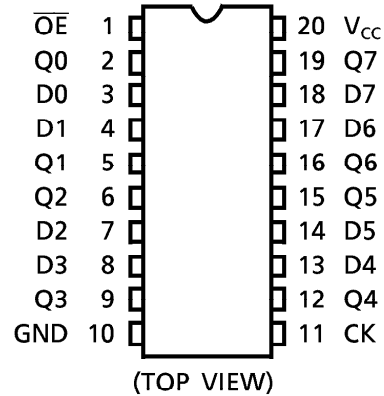
TRUTH TABLE

INPUTS			OUTPUT
OE	CK	D	
H	X	X	Z
L		X	Q_n
L		L	L
L		H	H

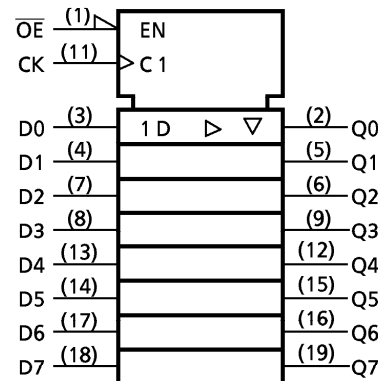
X : Don't Care
Z : High Impedance
 Q_n : No Change



PIN ASSIGNMENT



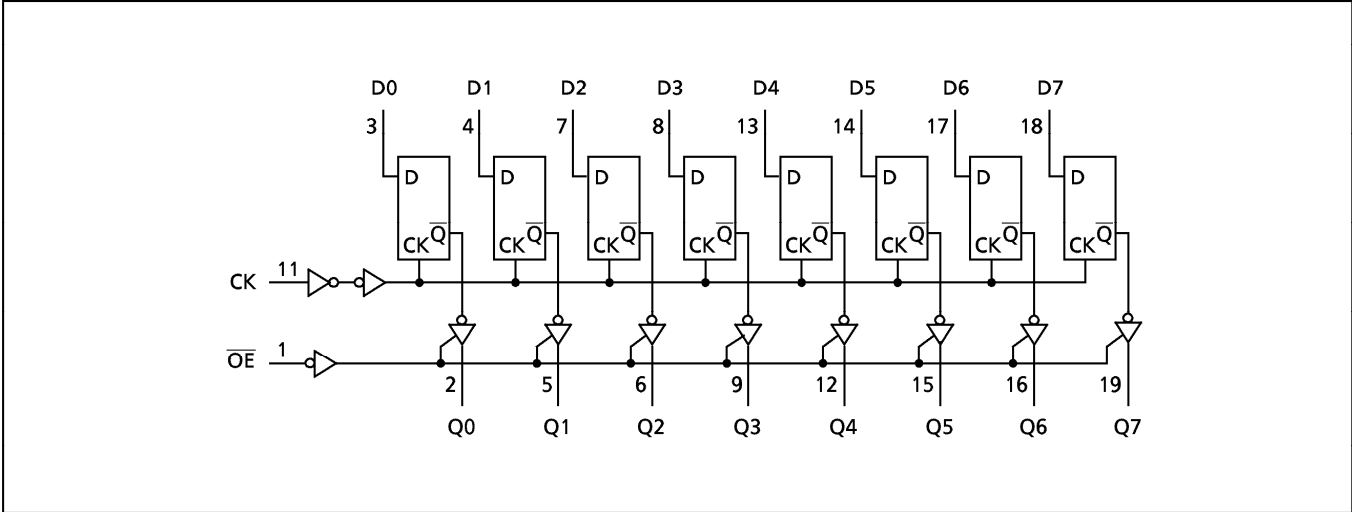
IEC LOGIC SYMBOL



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SYSTEM DIAGRAM



ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	V_{CC}	$-0.5 \sim 7.0$	V
DC Input Voltage	V_{IN}	$-0.5 \sim 7.0$	V
DC Output Voltage	V_{OUT}	$-0.5 \sim 7.0$ (Note 1)	V
		$-0.5 \sim V_{CC} + 0.5$ (Note 2)	
Input Diode Current	I_{IK}	-20	mA
Output Diode Current	I_{OK}	± 20 (Note 3)	mA
DC Output Current	I_{OUT}	± 25	mA
DC Vcc/Ground Current	I_{CC}	± 75	mA
Power Dissipation	P_D	180	mW
Storage Temperature	T_{stg}	$-65 \sim 150$	$^{\circ}C$

- (Note 1) Output in Off-State
- (Note 2) High or Low State. I_{OUT} absolute maximum rating must be observed.
- (Note 3) $V_{OUT} < GND$, $V_{OUT} > V_{CC}$

RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	V_{CC}	4.5~5.5	V
Input Voltage	V_{IN}	0~5.5	V
Output Voltage	V_{OUT}	0~5.5 (Note 4)	V
		0~ V_{CC} (Note 5)	
Operating Temperature	T_{opr}	$-40 \sim 85$	$^{\circ}C$
Input Rise and Fall Time	dt/dV	0~20	ns/V

- (Note 4) Output in Off-State
- (Note 5) High or Low State

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DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	CONDITON		$V_{CC}(V)$	$T_a = 25^{\circ}C$			$T_a = -40 \sim 85^{\circ}C$		UNIT
					MIN.	TYP.	MAX.	MIN.	MAX.	
High - Level Input Voltage	V_{IH}			4.5~5.5	2.0	—	—	2.0	—	V
Low - Level Input Voltage	V_{IL}			4.5~5.5	—	—	0.8	—	0.8	V
High - Level Output Voltage	V_{OH}	$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OH} = -50\mu A$	4.5	4.40	4.50	—	4.40	—	V
			$I_{OH} = -8mA$	4.5	3.94	—	—	3.80	—	
Low - Level Output Voltage	V_{OL}	$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OL} = 50\mu A$	4.5	—	0.0	0.10	—	0.10	V
			$I_{OL} = 8mA$	4.5	—	—	0.36	—	0.44	
3 - State Output Off - State Current	I_{OZ}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = V_{CC} \text{ or } GND$		5.5	—	—	± 0.25	—	± 2.50	μA
Input Leakage Current	I_{IN}	$V_{IN} = 5.5V \text{ or } GND$		0~5.5	—	—	± 0.1	—	± 1.0	
Quiescent Supply Current	I_{CC}	$V_{IN} = V_{CC} \text{ or } GND$		5.5	—	—	4.0	—	40.0	
	I_{CCT}	PER INPUT : $V_{IN} = 3.4V$ OTHER INPUT : $V_{CC} \text{ or } GND$		5.5	—	—	1.35	—	1.50	mA
Output Leakage Current	I_{OPD}	$V_{OUT} = 5.5V$		0	—	—	+0.5	—	+5.0	μA

TIMING REQUIREMENTS (Input $t_r = t_f = 3ns$)

PARAMETER	SYMBOL	TEST CONDITION	$V_{CC}(V)$	$T_a = 25^{\circ}C$		$T_a = -40 \sim 85^{\circ}C$	UNIT
				TYP .	LIMIT	LIMIT	
Minimum Pulse Width (CK)	$t_W(H)$ $t_W(L)$		5.0 ± 0.5	—	6.5	8.5	ns
Minimum Set - up Time	t_s		5.0 ± 0.5	—	2.5	2.5	
Minimum Hold Time	t_h		5.0 ± 0.5	—	2.5	2.5	

AC ELECTRICAL CHARACTERISTICS (Input $t_r = t_f = 3\text{ns}$)

PARAMETER	SYMBOL	TEST CONDITION			Ta = 25°C			Ta = − 40~85°C		UNIT
			V _{CC} (V)	CL (pF)	MIN.	TYP.	MAX.	MIN.	MAX.	
Propagation Delay Time (CK-Q)	t _{pLH}		5.0 ± 0.5	15	—	4.1	9.4	1.0	10.5	ns
	t _{pHL}			50	—	5.6	10.4	1.0	11.5	
3-State Output Enable Time	t _{pZL}	RL = 1kΩ	5.0 ± 0.5	15	—	6.5	10.2	1.0	11.5	
	t _{pZH}			50	—	7.3	11.2	1.0	12.5	
3-State Output Disable Time	t _{pLZ} t _{pHZ}	RL = 1kΩ	5.0 ± 0.5	50	—	7.0	11.2	1.0	12.0	
Maximum Clock Frequency	f _{MAX}		5.0 ± 0.5	15	90	140	—	80	—	
				50	85	130	—	95	—	
Output to Output Skew	t _{osLH} t _{osHL}	(Note 6)	5.0 ± 0.5	50	—	—	1.0	—	1.0	ns
Input Capacitance	C _{I N}				—	4	10	—	10	pF
Output Capacitance	C _{OUT}				—	9	—	—	—	
Power Dissipation Capacitance	C _{PD}	(Note 7)			—	25	—	—	—	

(Note 6) Parameter guaranteed by design. $t_{\text{osLH}} = |t_{\text{pLHm}} - t_{\text{pLHn}}|$, $t_{\text{osHL}} = |t_{\text{pHLm}} - t_{\text{pHLn}}|$

(Note 7) C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation :

$$I_{\text{CC(opr.)}} = C_{\text{PD}} \cdot V_{\text{CC}} \cdot f_{\text{IN}} + I_{\text{CC}} / 8 \text{ (per F/F)}$$

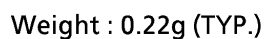
And the total C_{PD} when n pcs. of Latch operate can be gained by the following equation :

$$C_{\text{PD}}(\text{total}) = 14 + 11 \cdot n$$

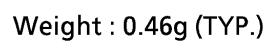
NOISE CHARACTERISTICS (Input $t_r = t_f = 3\text{ns}$)

PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C		UNIT	
			V _{CC} (V)	TYP.		MAX.
Quiet Output Maximum Dynamic V _{OL}	V _{OLP}	C _L = 50pF	5.0	1.2	1.6	V
Quiet Output Minimum Dynamic V _{OL}	V _{OLV}	C _L = 50pF	5.0	— 1.2	— 1.6	V
Minimum High Level Dynamic Input Voltage	V _{IHD}	C _L = 50pF	5.0	—	3.5	V
Maximum Low Level Dynamic Input Voltage	V _{ILD}	C _L = 50pF	5.0	—	1.5	V

Unit in mm



Unit in mm



TSSOP 20PIN OUTLINE DRAWING (TSSOP20-P-0044 -0.65)

Unit in mm

